# PowerPhase, Dual N-Channel SO8FL

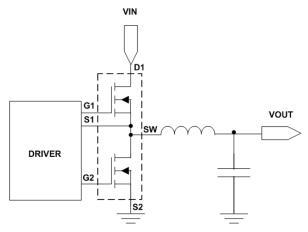
30 V, High Side 20 A / Low Side 32 A

# **Features**

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

- DC-DC Converters
- System Voltage Rails
- Point of Load



**Figure 1. Typical Application Circuit** 

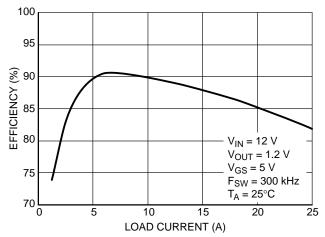


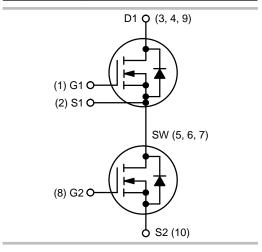
Figure 2. Typical Efficiency Performance POWERPHASEGEVB Evaluation Board



# ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
Q1 Top FET	5.4 mΩ @ 10 V	20.4
30 V	8.1 mΩ @ 4.5 V	20 A
Q2 Bottom	2.6 mΩ @ 10 V	32 A
FET 30 V	3.4 mΩ @ 4.5 V	32 A



# PIN CONNECTIONS D1 4 5 5 SW D1 3 9 10 6 SW S1 2 7 SW G1 1 6 SW S2 7 SW G1 1 6 SW S2 7 SW G1 1 6 SW



4C86N = Specific Device Code A = Assembly Location Y = Year

W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit		
Drain-to-Source Voltage	Q1	V <sub>DSS</sub>	30	V		
Drain-to-Source Voltage	Q2					
Gate-to-Source Voltage	Q1	V <sub>GS</sub>	±20	V		
Gate-to-Source Voltage	Q2					
Continuous Drain Current R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	14.8	
		T <sub>A</sub> = 85°C	1		10.7	1
		T <sub>A</sub> = 25°C	Q2		23.7	A
		T <sub>A</sub> = 85°C	1		17.1	
Power Dissipation	1	T <sub>A</sub> = 25°C	Q1	$P_{D}$	1.89	W
RθJA (Note 1)			Q2			
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$	1	T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	20.2	
		T <sub>A</sub> = 85°C			14.5	A A
	Steady	T <sub>A</sub> = 25°C	Q2		32.3	
	State	T <sub>A</sub> = 85°C	1		23.3	
Power Dissipation	1	T <sub>A</sub> = 25°C	Q1	$P_{D}$	3.51	W
$R_{\theta JA} \le 10 \text{ s (Note 1)}$			Q2			
Continuous Drain Current	1	T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	11.3	
R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C	1		8.1	1 .
		T <sub>A</sub> = 25°C	Q2		18.1	A
		T <sub>A</sub> = 85°C	1		13.0	
Power Dissipation	1	T <sub>A</sub> = 25 °C	Q1	$P_{D}$	1.10	W
R <sub>θJA</sub> (Note 2)			Q2			
Pulsed Drain Current	•	T <sub>A</sub> = 25°C	Q1	I <sub>DM</sub>	160	Α
		t <sub>p</sub> = 10 μs	Q2		280	
Operating Junction and Storage Temperature	Q1	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C		
	Q2					
Source Current (Body Diode)	Q1	I <sub>S</sub>	10	Α		
	Q2		10			
Drain to Source DV/DT		dV/dt	6	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (T.	Q1	EAS	20	mJ		
$V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, L = 0.1 \text{ mH}, R_G = 25 \Omega$				EAS	80	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T <sub>L</sub>	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 sq—in pad, 2 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Top) - Steady State (Note 3)	$R_{\theta JC}$	3.3	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	66.0	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	113.7	°C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	35.6	

- 3. Surface–mounted on FR4 board using 1 sq–in pad, 2 oz Cu.
  4. Surface–mounted on FR4 board using the minimum recommended pad size of 100 mm².

# FLECTRICAL CHARACTERISTICS (T.

Parameter	FET	Symbol	bol Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•			
Drain-to-Source Break-	Q1	.,			30			V
down Voltage	Q2	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V$ ,	$I_D = 250 \mu A$	30			
Drain-to-Source Break-	Q1	V <sub>(B,R)</sub> DSS				17		mV /
down Voltage Temperature Coefficient	Q2	/T <sub>J</sub>				16.5		°C′
Zero Gate Voltage Drain	Q1	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C			1	
Current			$V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 125°C			10	μΑ
	Q2		$V_{GS} = 0 \text{ V},$ $V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 25°C			1	μΑ
Gate-to-Source Leakage	Q1	I <sub>GSS</sub>	SS V <sub>GS</sub> = 0 V, VDS = +20 V				100	nA
Current	Q2						100	
ON CHARACTERISTICS (Not	e 5)							
Gate Threshold Voltage	Q1	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		1.3		2.2	V
	Q2				1.3		2.2	
Negative Threshold Temper-	Q1	V <sub>GS(TH)</sub> /				4.5		mV
ature Coefficient	Q2	1,1				4.6		°C
Drain-to-Source On Resist-	Q1	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		4.3	5.4	
ance			$V_{GS} = 4.5 \text{ V}$	I <sub>D</sub> = 18 A		6.5	8.1	
	Q2		$V_{GS} = 10 \text{ V}$ $I_D = 30 \text{ A}$ $V_{GS} = 4.5 \text{ V}$ $I_D = 12.5 \text{ A}$			1.7	2.6	— mΩ
						2.4	3.4	
CAPACITANCES								
Input Capacitance  Q1  Q2  Q1  Output Capacitance		0				1153		pF
		C <sub>ISS</sub>				3050		
		C <sub>OSS</sub> V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V		MHz V 15 V		532		
Output Oapacitarice	Q2	OSS	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, V}_{DS} = 15 \text{ V}$ $C_{RSS}$			1650		
Reverse Capacitance	Q1	Cooo				107		
Neverse Capacitance	<b>∩</b> 2	∨RSS				77		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

77

- 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

Q2

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition		Min	Тур	Max	Unit
CHARGES, CAPACITANCES	& GATE	RESISTANC	E				•	
T. 10 1 01	Q1				10.9			
Total Gate Charge	Q2	$Q_{G(TOT)}$				21.6		
T	Q1	_				1.2		
Threshold Gate Charge	Q2	Q <sub>G(TH)</sub>	V 45VV	45.77.1 00.4		1.4		
0-1-1-0	Q1	_	$V_{GS} = 4.5 \text{ V}, V_{DS}$	= 15 V; I <sub>D</sub> = 30 A		3.4		nC
Gate-to-Source Charge	Q2	$Q_GS$				8.6		
Onto to Danie Observe	Q1	0				5.4		
Gate-to-Drain Charge	Q2	$Q_GD$				5.5		
T. 10 . 0	Q1		.,	45.77.1 00.4		22.2		
Total Gate Charge	Q2	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS}$	= 15 V; I <sub>D</sub> = 30 A		47.5		nC
0 . 5	Q1	$R_{G}$	_			1.0		
Gate Resistance	Q2		ΙΑ =	25°C		1.0		Ω
SWITCHING CHARACTERIS	STICS (No	te 6)					•	
T 0 D   T	Q1					8.9		
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				8.3		
D: T	Q1					21.2		
Rise Time	Q2	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 15 \text{ A}, R_G = 3.0 \Omega$		15.1		
T 0"P   T	Q1	,	$I_D = 15 \text{ A},$	$R_G = 3.0 \Omega$		15.3		ns
Turn-Off Delay Time	Q2	t <sub>d(OFF)</sub>				19.3		
5 U.T.	Q1	,				4.4		1
Fall Time	Q2	t <sub>f</sub>				4.2		
SWITCHING CHARACTERIS	STICS (No	te 6)						
T O. Delevi T.	Q1					6.7		
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				6.3		
D'e e T'e e	Q1					19.5		
Rise Time	Q2	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,			13.8		1
T 0"P   T	Q1	,	$I_{\rm D} = 15  \rm A,$	$R_G = 3.0 \Omega$		20.1		ns
Turn-Off Delay Time	Q2	t <sub>d(OFF)</sub>	(OFF)			22.8		
	Q1					2.8		1
Fall Time	Q2	t <sub>f</sub>				3.2		
DRAIN-SOURCE DIODE CH	ARACTE	RISTICS				-	<u>-</u>	<u>-</u>
			$V_{GS} = 0 V$	T <sub>J</sub> = 25°C		0.80		
- W.	Q1	,,	$V_{GS} = 0 V$ , $I_S = 10 A$	T <sub>J</sub> = 125°C		0.60		] ,,
Forward Voltage	6.5	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.78	В	
	Q2		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.62		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Daviera Daviera Tima	Q1						
Reverse Recovery Time	Q2	t <sub>RR</sub>			33.7		ns
Charma Time	Q1	- ta			14.5		
Charge Time	Q2				17.4		
Dischause Times	Q1	4 la	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 30 \text{ A}$		14.6		
Discharge Time	Q2	tb	1		16.3		
Daviera Danaviani Chare	Q1	0			21		0
Reverse Recovery Charge	Q2	$Q_{RR}$			27.5		nC

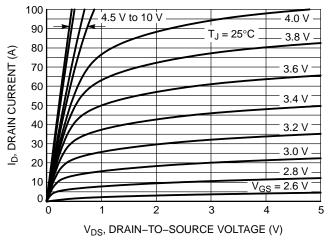
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS - Q1**

100

90

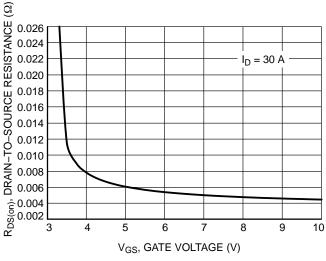
 $V_{DS} = 3 V$ 



80 ID, DRAIN CURRENT (A) 70 60 50 40 30 20  $T_J = 125^{\circ}C$ 10  $T_J = -55^{\circ}C$  $T_J = 25^{\circ}C$ 0.5 2.5 3.0 3.5 4.0 4.5 5.0 5.5 1.0 1.5 2.0 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 3. On-Region Characteristics

Figure 4. Transfer Characteristics



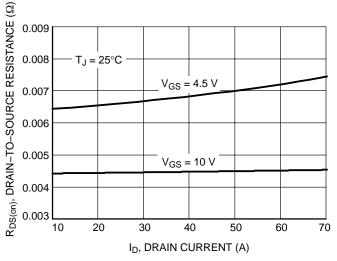
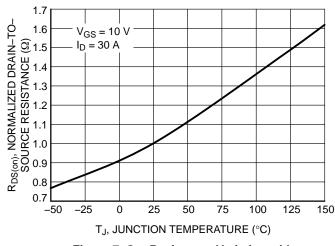


Figure 5. On-Resistance vs. Gate-to-Source Voltage

Figure 6. On-Resistance vs. Drain Current and Gate Voltage



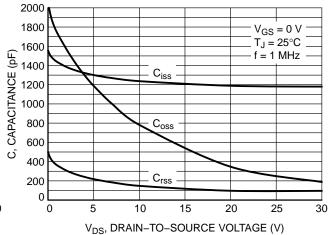


Figure 7. On–Resistance Variation with Temperature

Figure 8. Capacitance Variation

#### **TYPICAL CHARACTERISTICS - Q1**

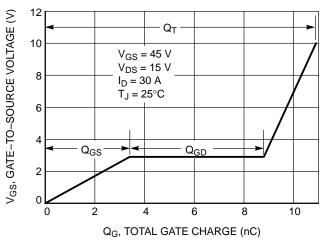


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

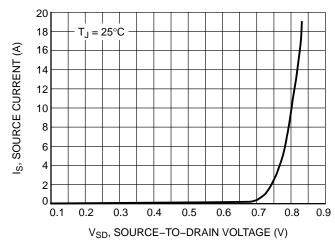


Figure 10. Diode Forward Voltage vs. Current

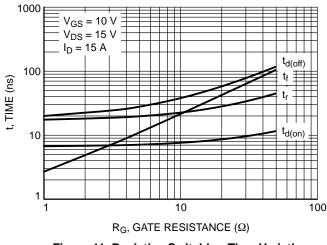


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

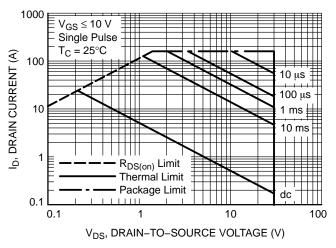


Figure 12. Maximum Rated Forward Biased Safe Operating Area

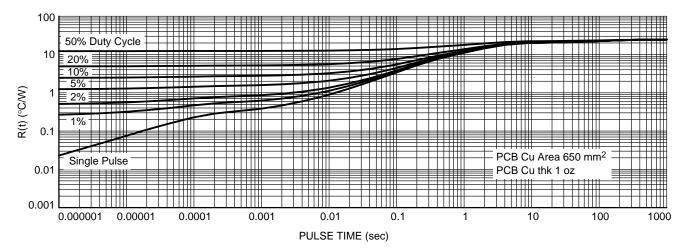
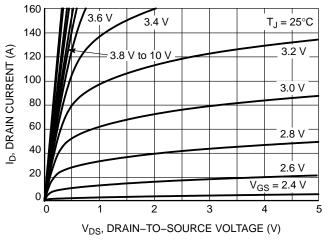


Figure 13. Thermal Characteristics

#### **TYPICAL CHARACTERISTICS - Q2**

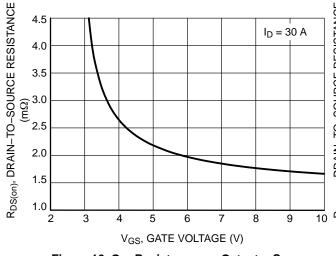
160



 $V_{DS} = 3 V$ 140 ID, DRAIN CURRENT (A) 120 100 80 60  $T_{.J} = 125^{\circ}C$ 40 -55°C 20  $T_J = 25^{\circ}C$ 0 0.5 0 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 14. On-Region Characteristics

Figure 15. Transfer Characteristics



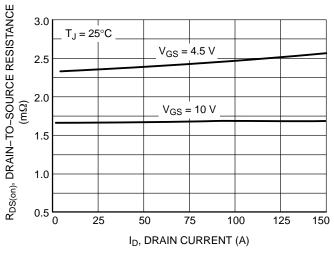
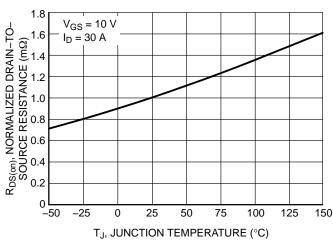


Figure 16. On-Resistance vs. Gate-to-Source Voltage

Figure 17. On–Resistance vs. Drain Current and Gate Voltage



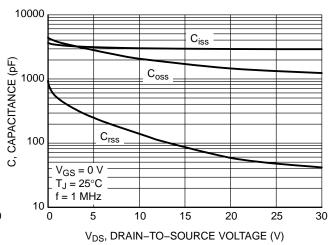


Figure 18. On–Resistance Variation with Temperature

Figure 19. Capacitance Variation

# **TYPICAL CHARACTERISTICS - Q2**

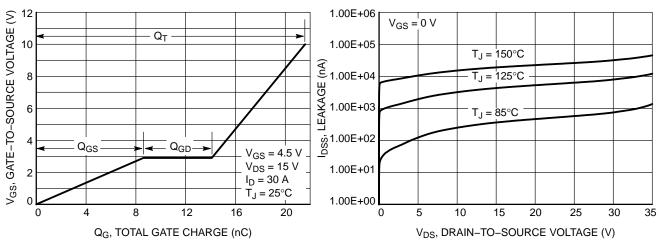


Figure 20. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

Figure 21. Drain-to-Source Leakage Current vs. Voltage

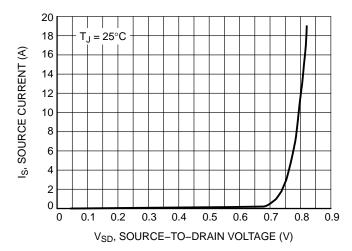


Figure 22. Diode Forward Voltage vs. Current

#### **TYPICAL CHARACTERISTICS - Q2**

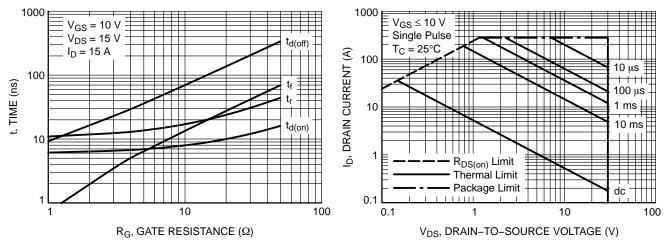


Figure 23. Resistive Switching Time Variation vs. Gate Resistance

Figure 24. Maximum Rated Forward Biased Safe Operating Area

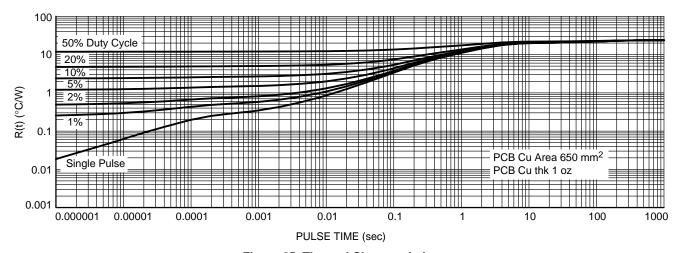


Figure 25. Thermal Characteristics

#### **ORDERING INFORMATION**

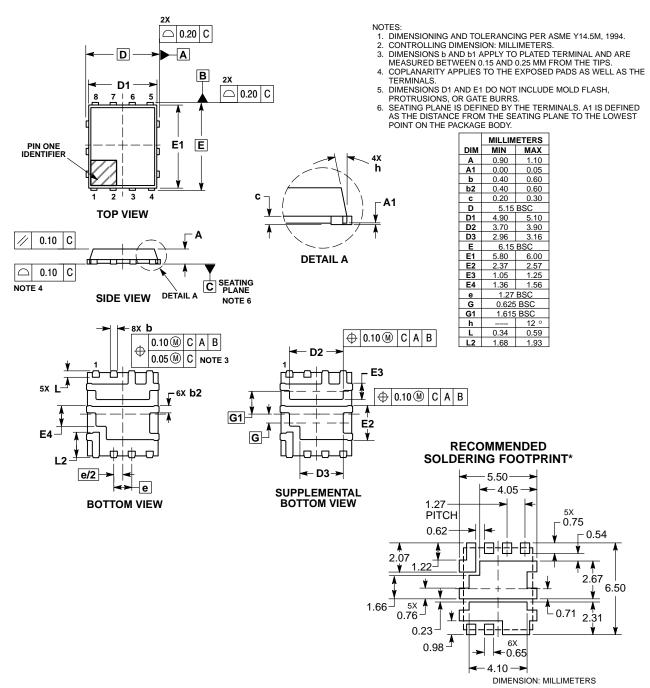
Device	Package	Shipping <sup>†</sup>
NTMFD4C86NT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4C86NT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# DFN8 5x6, 1.27P PowerPhase FET

CASE 506CR ISSUE C



<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="https://www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor dates sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify a

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative